

NOTICE OF REFERENCES CITED

APPLICANT(S)

Chiu et al

U.S. PATENT DOCUMENTS

*	DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE
A	5073387	12-17-91	Whistler	426	444	1-24-90
B						
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K						

FOREIGN PATENT DOCUMENTS

*	DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUB-CLASS	PERTINENT SHTS. DWG.	PP. DWG.	SPEC.
L									
M									
N									
O									
P									
Q									

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER

JOSEPH GOLIAN
PRIMARY EXAMINER

DATE

4-13-92

ART UNIT 132* A copy of this reference is not being furnished with this office action.
(See Manual of Patent Examining Procedure, section 707.05 (a).)

Form PTO-1449 (REV. 7/80)		U.S. Department of Commerce Patent and Trademark Office		Atty. Docket No. #1358		Serial No. 07/525,943	
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)		Applicant					
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		Filing Date May 17, 1990		Group 132			
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*Examiner's Initial	TRADEMARK OFF	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
<i>J. D. D.</i>	AA	3,399,189	8/27/68	Arthur L. Gordon	260	209	
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		Document Number	Date	Country	Class	Subclass	Translation
<i>J. D. D.</i>	AL	WO 91/11112	8/8/91	PCT	—	—	
<i>J. D. D.</i>	AM	210965/87	9/17/87	Japan	—	—	X
	AN						
	AO						
	AP						
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	AR						
	AS						
EXAMINER: <i>JOSEPH DOLIAN</i> <i>JONATHAN KATZMAN</i>				DATE CONSIDERED			
<i>4-13-92</i>							
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							